

Notice of References Cited		Application/Control No. 10/635,969	Applicant(s)/Patent Under Reexamination KIM ET AL.	
		Examiner Thao P. Le	Art Unit 2818	Page 1 of 1

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	C	US-6,117,756	09-2000	Wu, Shye-Lin	438/594
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	M	US-			

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NON-PATENT DOCUMENTS

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